

<b>Notice of References Cited</b>	Application/Control No. 10/748,220	Applicant(s)/Patent Under Reexamination FARACHI ET AL.	
	Examiner Rodney H. Bonck	Art Unit 3681	Page 1 of 1

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	B	US-5,393,274	02-1995	Smedley, Daniel G.	477/74
	C	US-2005/0043139 A1	02-2005	Kennedy, Ian Duncan	477/098
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	L	US-			
	M	US-			

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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
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